

TEST REPORT

of

FCC Part 15 Subpart C §15.247
IC RSS-247 Issue 4 and RSS-Gen Issue 5

FCC ID: A3LSMR540L
IC Certification: 649E-SMR540L

Equipment Under Test : Bluetooth Headset
Model Name : SM-R540
Variant Model Name(s) : -
FCC Applicant : Samsung Electronics Co Ltd
IC Applicant : SAMSUNG ELECTRONICS CO. LTD.
Manufacturer : Samsung Electronics Co., Ltd.
Date of Receipt : 2025.11.18
Date of Test(s) : 2025.11.19 ~ 2025.12.19
Date of Issue : 2025.12.24

In the configuration tested, the EUT complied with the standards specified above. This test report does not assure KOLAS accreditation.

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- 2) The SGS Korea is not responsible for the sampling, the results of this test report apply to the sample as received.
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Tested by:



Dave Kim

Technical
Manager:



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SGS Korea Co., Ltd. Gunpo Laboratory

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1. General Information

1.1 Testing Laboratory

SGS Korea Co., Ltd. (Gunpo Laboratory)

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- Designation number: KR0150

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1.2. Details of Applicant

FCC Applicant : Samsung Electronics Co Ltd

FCC Address : 19 Chapin Rd., Building D, Pine Brook, New Jersey, United States, 07058

IC Applicant : SAMSUNG ELECTRONICS CO. LTD.

IC Address : 129 Samsung-ro, Yeongtong-gu, Suwon-Si, Gyeonggi-do, Korea (Republic Of), 16677

Contact Person : Chun, Jenni

Phone No. : +1 973 808 6375

1.3. Details of Manufacturer

Company : Samsung Electronics Co., Ltd.

Address : 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, Republic of Korea, 16677

1.4. Description of EUT

Kind of Product	Bluetooth Headset
Model Name	SM-R540
HVIN	SM-R540L
Serial Number	Conducted: SM-R540_1 Radiated: SM-R540_3
Power Supply	DC 3.85 V
Frequency Range	2 402 MHz ~ 2 480 MHz (Bluetooth)
Modulation Technique	GFSK, $\pi/4$ DQPSK, 8DPSK
Number of Channels	79 channels (Bluetooth)
Antenna Type	Metal Antenna
Antenna Gain*	-9.30 dB i
H/W Version	1.0
S/W Version	R540.001
FVIN	N/A

1.5. Information about the FHSS characteristics:

1.5.1. Pseudorandom Frequency Hopping Sequence

The channel is represented by a pseudo-random hopping sequence hopping through the 79 RF channels. The hopping sequence is unique for the piconet and is determined by the Bluetooth device address of the master; the phase in the hopping sequence is determined by the Bluetooth clock of the master. The channel is divided into time slots where each slot corresponds to an RF hop frequency. Consecutive hops correspond to different RF hop frequencies. The nominal hop rate is 1 600 hops/s.

1.5.2. Equal Hopping Frequency Use

The channels of this system will be used equally over the long-term distribution of the hopsets.

1.5.3. Example of a 79 hopping sequence in data mode:

02, 05, 31, 24, 20, 10, 43, 36, 30, 23, 40, 06, 21, 50, 44, 09, 71, 78, 01, 13, 73, 07, 70, 72, 35, 62, 42, 11, 41, 08, 16, 29, 60, 15, 34, 61, 58, 04, 67, 12, 22, 53, 57, 18, 27, 76, 39, 32, 17, 77, 52, 33, 56, 46, 37, 47, 64, 49, 45, 38, 69, 14, 51, 26, 79, 19, 28, 65, 75, 54, 48, 03, 25, 66, 05, 16, 68, 74, 59, 63, 55

1.5.4. System Receiver Input Bandwidth

Each channel bandwidth is 1 MHz.

The system receivers have input bandwidths that match the hopping channel bandwidths of their corresponding transmitters and shift frequencies in synchronization with the transmitted signals.

1.5.5. Equipment Description

RSS-247 Issue 4, 6.2.1(a): The system receivers shall have input bandwidths that match the hopping channel bandwidths of their corresponding transmitters and shall shift frequencies in synchronization with the transmitted signals.

RSS-247 Issue 4, 3: Frequency hopping systems(FHS) employ a spread spectrum technology in which the carrier is modulated with coded information in a conventional manner, causing a conventional spreading of the radio frequency (RF) energy around the carrier frequency. The carrier frequency is not fixed, but changes at fixed intervals under the direction of a coded sequence.

FHS are not required to employ all available hopping frequencies during each transmission. However, the system comprising both the transmitter and the receiver, must be designed to comply with all of the requirements in this section in case the transmitter is presented with a continuous data or information stream. In addition, a system employing short transmission bursts must comply with the definition of frequency hopping equipment and must distribute its transmissions over the minimum number of hopping channels specified in this section.

Incorporation of intelligence into an FHS that enables it to recognize other users of the band and to avoid occupied frequencies is permitted, provided that the FHS chooses or adapts its hopset without having to synchronize with another or several other systems. The coordination of FHS in any other manner for the express purpose of avoiding the simultaneous occupancy of individual hopping frequencies by multiple transmitters is not permitted.

1.6. Test Equipment List

Equipment	Manufacturer	Model	S/N	Cal. Due	Cal. Interval
Signal Generator	R&S	SMA100B	106887	10/20/2026	Annual
Spectrum Analyzer	R&S	FSV30	103453	10/17/2026	Annual
Spectrum Analyzer	Agilent	N9020A	MY53421758	09/10/2026	Annual
Spectrum Analyzer	Agilent	N9030A	US51350132	12/03/2026	Annual
DC Power Supply	Agilent	U8002A	MY54110041	09/18/2026	Annual
Bluetooth Tester	TESCOM	TC-3000C	3000C000560	09/10/2026	Annual
Directional Coupler	KRYTAR	152613	122660	07/02/2026	Annual
Bridge Coupler	MARKI MICROWAVE INC	CBR16-0012	1542	05/15/2026	Annual
Power Sensor	R&S	NRP-Z81	100669	05/24/2026	Annual
Preamplifier	H.P.	8447F	2944A03909	08/07/2026	Annual
Preamplifier	TESTEK	TK-PA1840H	130016	03/13/2026	Annual
Signal Conditioning Unit	R&S	SCU-18F	101058	02/27/2026	Annual
EMI Test Receiver	R&S	ESU26	100109	01/13/2026	Annual
High Pass Filter	Wainwright Instrument GmbH	WHKX3.0/18G-10SS	21	06/17/2026	Annual
High Pass Filter	Wainwright Instrument GmbH	WHNX7.5/26.5G-6SS	15	06/09/2026	Annual
Low Pass Filter	Mini-Circuits	NLP-1200+	V8979400903-2	02/04/2026	Annual
Loop Antenna	Schwarzbeck Mess- Elektronik	FMZB 1519	1519-039	10/01/2027	Biennial
Bilog Antenna	Schwarzbeck Mess- Elektronik	VULB 9163	01126	03/05/2027	Biennial
Horn Antenna	R&S	HF906	100326	02/24/2026	Annual
Horn Antenna	Schwarzbeck Mess- Elektronik	BBHA 9170	9170-540	12/05/2026	Annual
Turn Table	Innco systems GmbH	DS 1200 S	N/A	N.C.R.	N/A
Controller	Innco systems GmbH	CONTROLLER CO3000-4P	CO3000/963/3833 0516/L	N.C.R.	N/A
Antenna Mast	Innco systems GmbH	MA4640-XP-ET	MA4640/536/3833 0516/L	N.C.R.	N/A
Anechoic Chamber	SY Corporation	L x W x H (9.6 m x 6.4 m x 6.6 m)	N/A	N.C.R.	N/A
Coaxial Cable	SENSORVIEW	NMST-13A26-NMST-5 m	TPC2402190004	04/13/2026	Semi-Annual
Coaxial Cable	SENSORVIEW	NMST-13A26-NMST-10 m	TPC2402190001	04/13/2026	Semi-Annual
Coaxial Cable	RFONE	PL360P-292M292M- 1.5M-A	20200324002	04/10/2026	Semi-Annual
Coaxial Cable	RADIALL	TESTPRO 3	182287	04/10/2026	Semi-Annual
Coaxial Cable	RADIALL	TESTPRO 3	182284	04/10/2026	Semi-Annual

Note;

For equipment listed above that has a calibration date or calibration due date that falls within the test date range, care was taken to ensure that this equipment was used after the calibration date and before the calibration due date

1.7. Declaration by the Manufacturer

- Adaptive Frequency Hopping is supported and use at least 20 channels.

1.8. Summary of Test Results

The EUT has been tested according to the following specifications:

APPLIED STANDARD: FCC Part15 Subpart C, IC RSS-247 Issue 4 and RSS-Gen Issue 5			
Section in FCC	Section in IC	Test Item(s)	Result
15.205(a) 15.209 15.247(d)	RSS-247 Issue 4 6.6 RSS-Gen Issue 5 8.9	Transmitter Radiated Spurious Emissions and Conducted Spurious Emission	Pass
15.247(a)(1)	RSS-247 Issue 4 6.2.3.1(a) RSS-Gen Issue 5 6.7	20 dB Bandwidth and 99 % Bandwidth	Pass
15.247(a)(1) 15.247(b)(1)	RSS-247 Issue 4 6.2.3.1(a) 6.2.3.2(a)(b)(c)	Maximum Peak Conducted Output Power	Pass
15.247(a)(1)	RSS-247 Issue 4 6.2.3.1(a)	Carrier Frequency Separation	Pass
15.247(a)(1)(iii)	RSS-247 Issue 4 6.2.3.1(b)	Number of Hopping Frequencies	Pass
15.247(a)(1)(iii)	RSS-247 Issue 4 6.2.3.1(b)	Time of Occupancy (Dwell Time)	Pass
15.207	RSS-Gen Issue 5 8.8	AC Power Line Conducted Emission	N/A ¹⁾

Note;

1) The AC power line test was not performed because the EUT use battery power for operation and which do not operate from the AC power lines.

1.9. Test Procedure(s)

The measurement procedures described in the American National Standard of Procedure for Compliance Testing of Unlicensed Wireless Devices (ANSI C63.10-2020+Cor.1-2023) was used in the measurement of the DUT.

1.10. Sample Calculation

Where relevant, the following sample calculation is provided:

1.10.1. Conducted Test

Offset value (dB) = Directional coupler (dB) + Cable loss (dB)

1.10.2. Radiation Test

Field strength level (dB μ V/m) = Measured level (dB μ V) + Antenna factor (dB/m) + Cable loss (dB) - Amplifier gain (dB)
+ Duty factor (dB)

1.11. Information of software for test

- Using the software of BudsOdin2.0 to testing of EUT.

1.12. Measurement Uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the apparatus:

Parameter	Uncertainty	
Maximum Peak Conducted Output Power	0.31 dB	
99 % Bandwidth	7.83 kHz	
20 dB Bandwidth	6.84 kHz	
Conducted Spurious Emission	0.91 dB	
Time of Occupancy	0.01 ms	
Radiated Emission, 9 kHz to 30 MHz	H	3.60 dB
	V	3.60 dB
Radiated Emission, below 1 GHz	H	5.50 dB
	V	5.10 dB
Radiated Emission, above 1 GHz	H	3.50 dB
	V	3.40 dB

All measurement uncertainty values are shown with a coverage factor $k = 2$ to indicate a 95 % level of confidence.

1.13. Test Report Revision

Revision	Report Number	Date of Issue	Description
0	F690501-RF-RTL006636	2025.12.24	Initial

1.14. Descriptions of Test Mode

Preliminary tests were performed in different data rates and recorded the RF output power in the following table:

Mode	Data Rate (Mbps)	Channel	Frequency (MHz)	RF Peak Output Power (dB m)
GFSK	1	Low	2 402	10.94
		Middle	2 441	10.89
		High	2 480	<u>11.86</u>
$\pi/4$ DQPSK	2	Low	2 402	10.34
		Middle	2 441	10.34
		High	2 480	<u>11.05</u>
8DPSK	3	Low	2 402	10.78
		Middle	2 441	10.74
		High	2 480	<u>11.86</u>

Note;

For transmitter radiated spurious emissions, conducted spurious emission, carrier frequency separation and number of hopping frequencies, GFSK / DH5 and 8DPSK / 3DH5 are tested as worst condition.

For 20 dB bandwidth and maximum peak conducted output power, GFSK / DH5, $\pi/4$ DQPSK / 2DH5 and 8DPSK / 3DH5 are tested as worst condition.

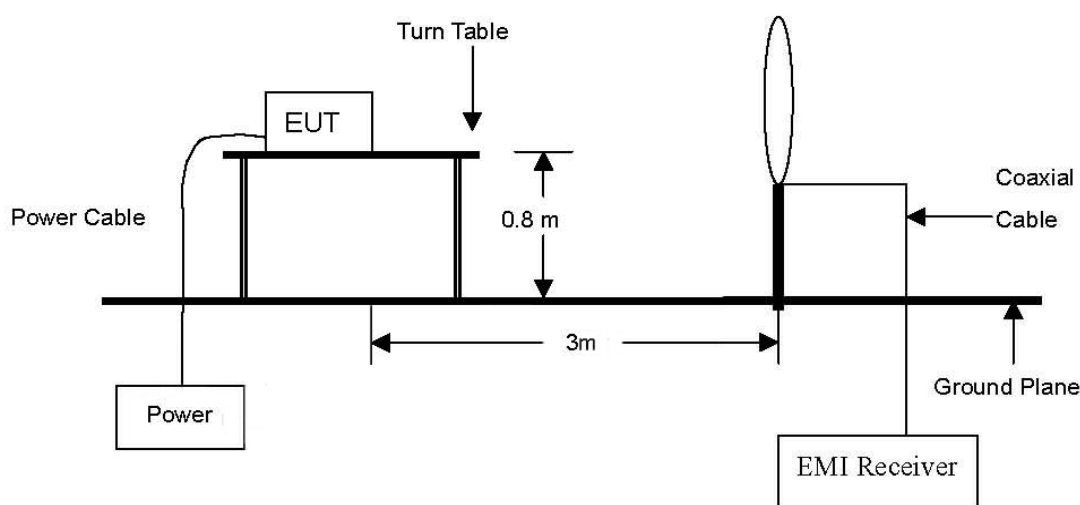
For Time of Occupancy, GFSK / DH1, DH3, DH5 and 8DPSK / 3DH1, 3DH3, 3DH5 are tested as worst condition.

2. Transmitter Radiated Spurious Emissions and Conducted Spurious Emissions

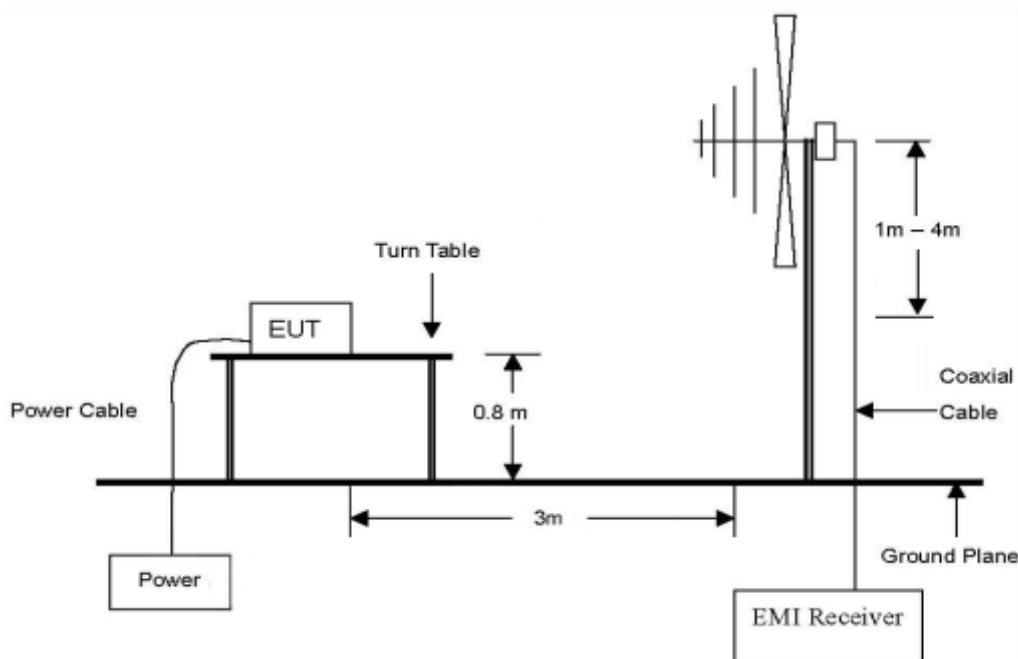
2.1. Test Setup

2.1.1. Transmitter Radiated Spurious Emissions

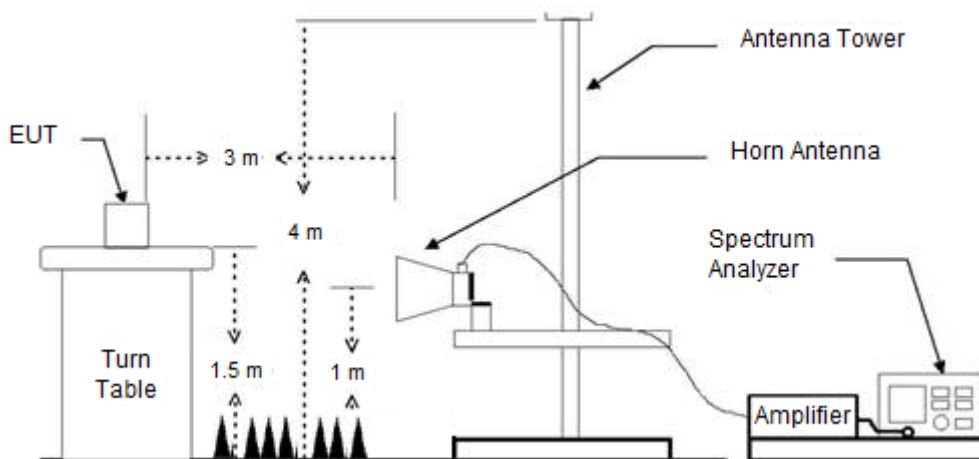
The diagram below shows the test setup that is utilized to make the measurements for emission from 9 kHz to 30 MHz.



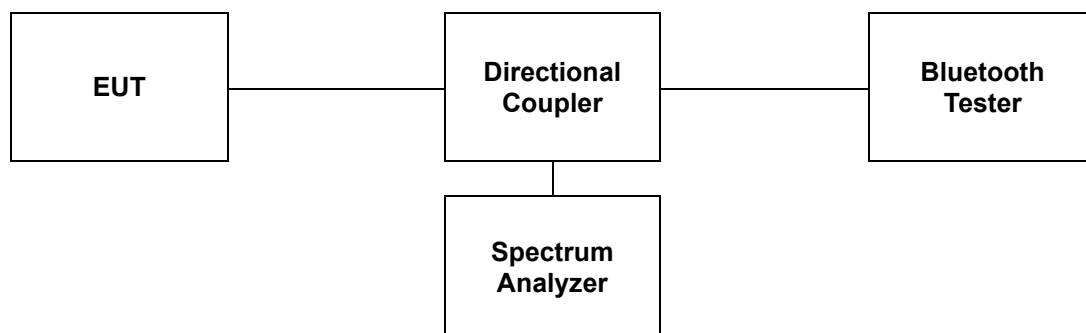
The diagram below shows the test setup that is utilized to make the measurements for emission from 30 MHz to 1 GHz.



The diagram below shows the test setup that is utilized to make the measurements for emission. The spurious emissions were investigated from 1 GHz to the 10th harmonic of the highest fundamental frequency or 40 GHz, whichever is lower.



2.1.2. Conducted Spurious Emissions



2.2. Limit

2.2.1. FCC

According to §15.247(d), in any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in §15.209(a) is not required. In addition, radiated emission which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).

According to §15.209(a), except as provided elsewhere in this subpart, the emissions from an intentional radiator shall not exceed the field strength levels specified in the following table:

Frequency (MHz)	Field Strength ($\mu\text{V/m}$)	Measurement Distance (Meters)
0.009-0.490	2 400/F(kHz)	300
0.490-1.705	24 000/F(kHz)	30
1.705-30.0	30	30
30-88	100**	3
88-216	150**	3
216-960	200**	3
Above 960	500	3

** Except as provided in paragraph (g), fundamental emissions from intentional radiators operating under this section shall not be located in the frequency bands 54-72 MHz, 76-88 MHz, 174-216 MHz or 470-806 MHz. However, operation within these frequency bands is permitted under other sections of this part, e.g., §§15.231 and 15.241.

2.2.2. IC

According to RSS-247 Issue 4, 6.6, In any 100 kHz bandwidth outside the frequency band in which the spread spectrum device, digitally modulated device, or hybrid system is operating, the RF power that is produced shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power – based on either an RF conducted or a radiated measurement– provided that the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of root-mean-square averaging over a time interval, as permitted under section 6.3.2, the attenuation required shall be 30 dB instead of 20 dB. Attenuation below the general field strength limits specified in RSS-Gen is not required.

According to RSS-Gen Issue 5, 8.9, except where otherwise indicated in the applicable RSS, radiated emissions shall comply with the field strength limits shown in table 5 and table 6. Additionally, the level of any transmitter unwanted emission shall not exceed the level of the transmitter's fundamental emission.

Table 5 – General Field Strength Limits at frequencies above 30 MHz

Frequency (MHz)	Field Strength ($\mu V/m$ at 3 m)
30-88	100
88-216	150
216-960	200
Above 960	500

Table 6 – General Field Strength Limits at frequencies below 30 MHz

Frequency	Magnetic Field Strength (H-Field) ($\mu A/m$)	Measurement Distance (meters)
9-490 kHz ¹	6.37/F (F in kHz)	300
490-1 705 kHz	63.7/F (F in kHz)	30
1.705-30 MHz	0.08	30

Note¹: The emission limits for the ranges 9-90 kHz and 110-490 kHz are based on measurements employing a linear average detector.

2.3. Test Procedures

Radiated emissions from the EUT were measured according to the dictates in section 11.11 & 11.12 of ANSI C63.10-2020+Cor.1-2023

2.3.1. Test Procedures for emission below 30 MHz

1. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 meter anechoic chamber test site. The table was rotated 360 degrees to determine the position of the highest radiation.
2. Then antenna is a loop antenna is fixed at one meter above the ground to determine the maximum value of the field strength. Both parallel and perpendicular of the antenna are set to make the measurement.
3. For each suspected emission, the EUT was arranged to its worst case and then the table was turned from 0 degrees to 360 degrees to find the maximum reading.
4. The test-receiver system was set to average or quasi peak detect function and Specified Bandwidth with Maximum Hold Mode.

2.3.2. Test Procedures for emission from above 30 MHz

1. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 meter anechoic chamber test site below 1 GHz and 1.5 meter above the ground at a 3 meter anechoic chamber test site above 1 GHz. The table was rotated 360 degrees to determine the position of the highest radiation.
2. During performing radiated emission below 1 GHz, the EUT was set 3 meters away from the interference receiving antenna, which was mounted on the top of a variable-height antenna tower. During performing radiated emission above 1 GHz, the EUT was set 3 meter away from the interference-receiving antenna.
3. The antenna is a bi-log antenna, a horn antenna and its height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
4. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the table was turned from 0 degrees to 360 degrees to find the maximum reading.
5. For measurements below 1 GHz resolution bandwidth is set to 100 kHz for peak detection measurements or 120 kHz for quasi-peak detection measurements. Peak detection is used unless otherwise noted as quasi-peak.
6. For measurements Above 1 GHz resolution bandwidth is set to 1 MHz, the video bandwidth is set to 3 MHz for peak measurements.

2.3.3. Test Procedures for Average measurements

Radiated emissions for average measurements were according to section 7.8.8.2 of ANSI C63.10-2020+Cor.1-2023

Where average measurements of an emission are required it is permitted to determine the average value over 100 ms after accounting for the maximum dwell time per 1 MHz in any 100 ms period. The dwell time in any 100 ms period can include multiple hops on that frequency for devices which have a short dwell time.

The maximum dwell time per 1 MHz does need to account for cases where the channel spacing is less than the 1 MHz measurement bandwidth and for cases where the occupied bandwidth exceeds the channel spacing and the channels overlap. The maximum dwell time per 1 MHz is determined as follows:

Maximum dwell time per 1 MHz = dwell time per 100 ms per channel × (channel separation correction + overlapping channel correction) where:

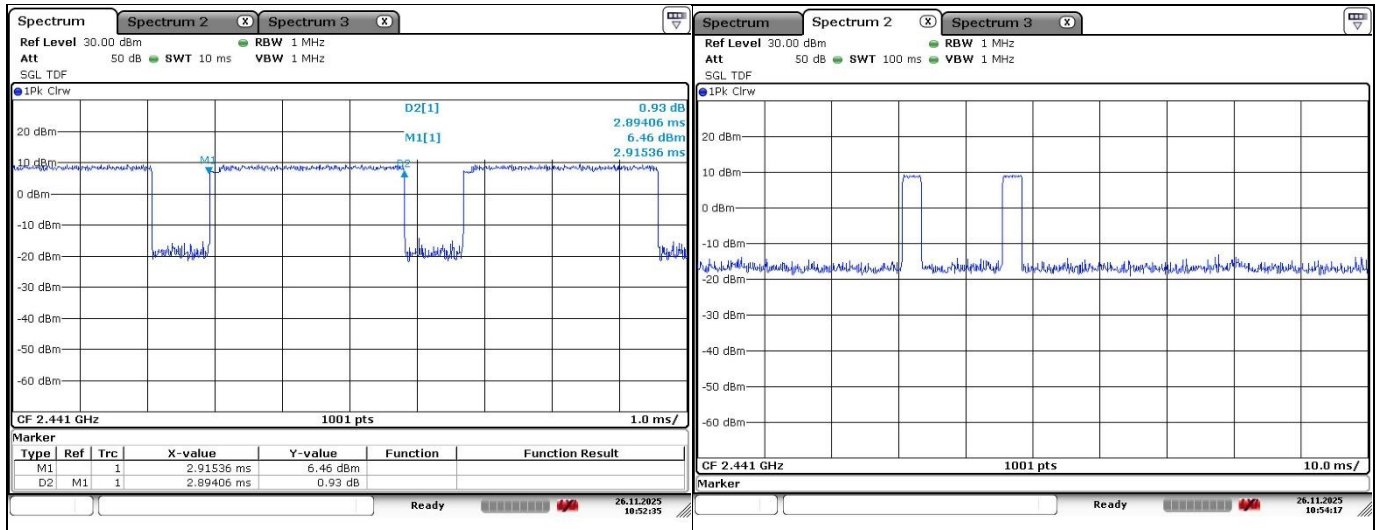
- Channel separation correction = $[1 / \text{channel separation (MHz)}]$ for channel separation < 1 MHz, and = 1 for channel separation ≥ 1 MHz, as determined using the procedures of 7.8.2. If the average measurements are performed on the Nth harmonic, the channel separation value is N times the separation at the fundamental frequency.
- Overlapping channel correction = 0 when the 20 dB channel bandwidth < channel separation and 1 for when the 20 dB channel bandwidth > channel separation.

The average value may be determined as follows:

- a) From the peak value of the emission: The measured peak value in dB μ V/m is corrected by $20 \log(\text{maximum dwell time in 100 ms} / 100)$.
- b) From the average value of the emission: When the average value has been measured with the device continuously transmitting (100% duty cycle) the measured average value in dB μ V/m is corrected by $X \log(\text{maximum dwell time in 100 ms} / 100)$ where X = 10 if using an rms-average power detector (with output data in power terms) and X = 20 if using a linear voltage average detector (with output data in voltage terms).

on time on Channel

dwelt time per 100 ms per channel



In AFH mode, the minimum hopping frequencies are 20, to get the longest dwell time 3DH5 packet is observed.

the period to have 3DH5 packet completing one hopping sequence is $2.89 \text{ ms} \times 20 \text{ channels} = 57.80 \text{ ms}$

There cannot be 2 complete hopping sequences within 100 ms period, considering the random hopping behavior, maximum 2 hops can be possibly observed within the period. $[100 \text{ ms} / 57.80 \text{ ms}] = 2 \text{ hops}$

Thus, the possible dwell time per 100 ms per channel:

$$2.89 \text{ ms} \times 2 = 5.78 \text{ ms}$$

For the 3DH5, the channel separation is 1 MHz, Channel separation correction = 1

For the 3DH5, 20 dB channel bandwidth > channel separation, Overlapping channel correction = 1

Maximum dwell time in 100 ms = dwell time per 100 ms per channel $\times$ (channel separation correction + overlapping channel correction)

$$5.78 \text{ ms} \times (1 + 1) = 11.56 \text{ ms}$$

Correction factor for average value is follow:

$$20 \times \log(11.56 \text{ ms}/100 \text{ ms}) = -18.74 \text{ dB}$$

2.3.4. Test Procedures for Conducted Spurious Emissions

2.3.4.1. Band-edge Compliance of RF Conducted Emissions

The transmitter output was connected to the spectrum analyzer.

Span = wide enough to capture the peak level of the emission operating on the channel closest to the band edge, as well as any modulation products which fall outside of the authorized band of operation.

RBW $\geq$ 100 kHz

VBW = 300 kHz

Sweep = auto

Detector function = peak

Trace = max hold

2.3.4.2. Spurious RF Conducted Emissions

The transmitter output was connected to the spectrum analyzer.

RBW = 1 MHz

VBW = 3 MHz

Sweep = auto

Detector function = peak

Trace = max hold

2.3.4.3. TDF function

- For plots showing conducted spurious emissions from 9 kHz to 25 GHz, all path loss of wide frequency range was investigated and compensated to spectrum analyzer as TDF function.

So, the reading values shown in plots were final result.

2.4. Test Results

Ambient temperature : $(23 \pm 1) ^\circ\text{C}$
Relative humidity : 47 %

2.4.1. Radiated Spurious Emission below 1 000 MHz

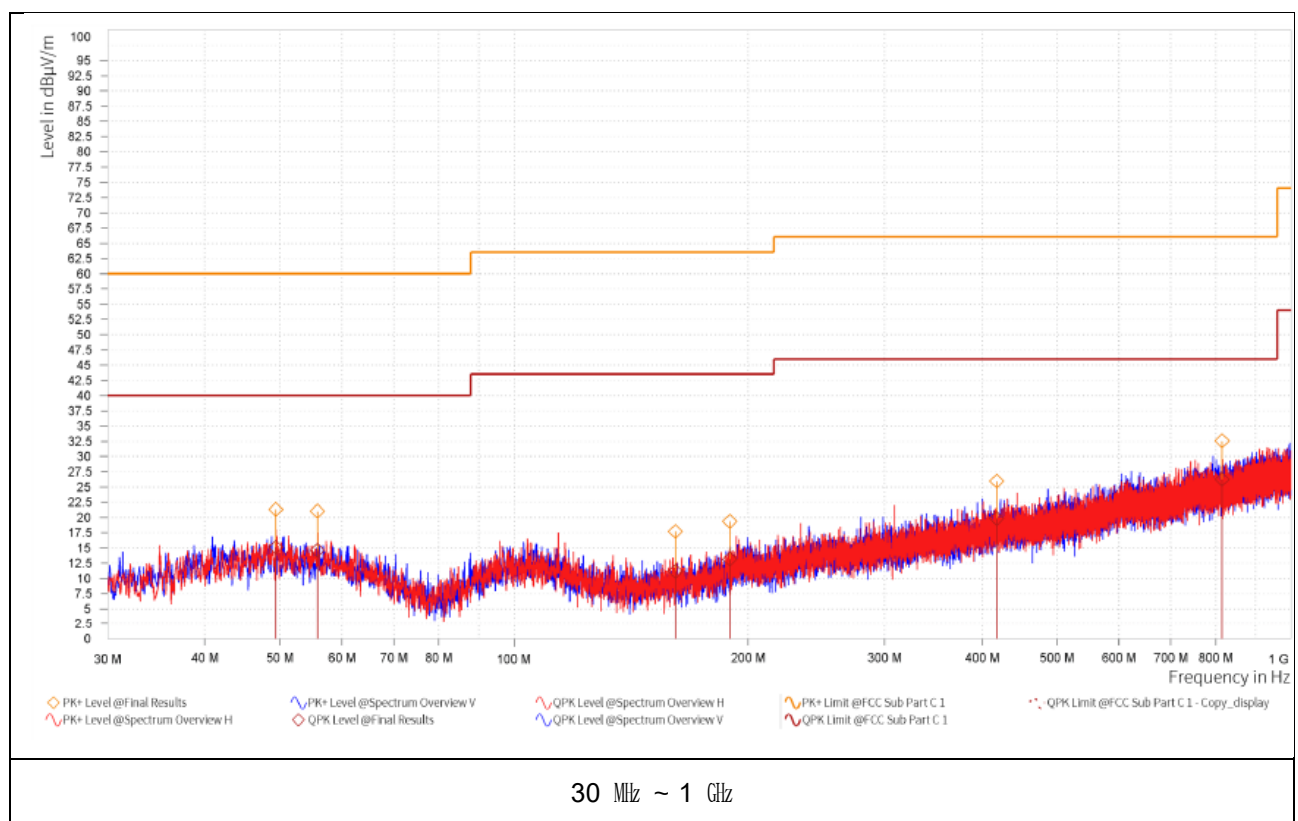
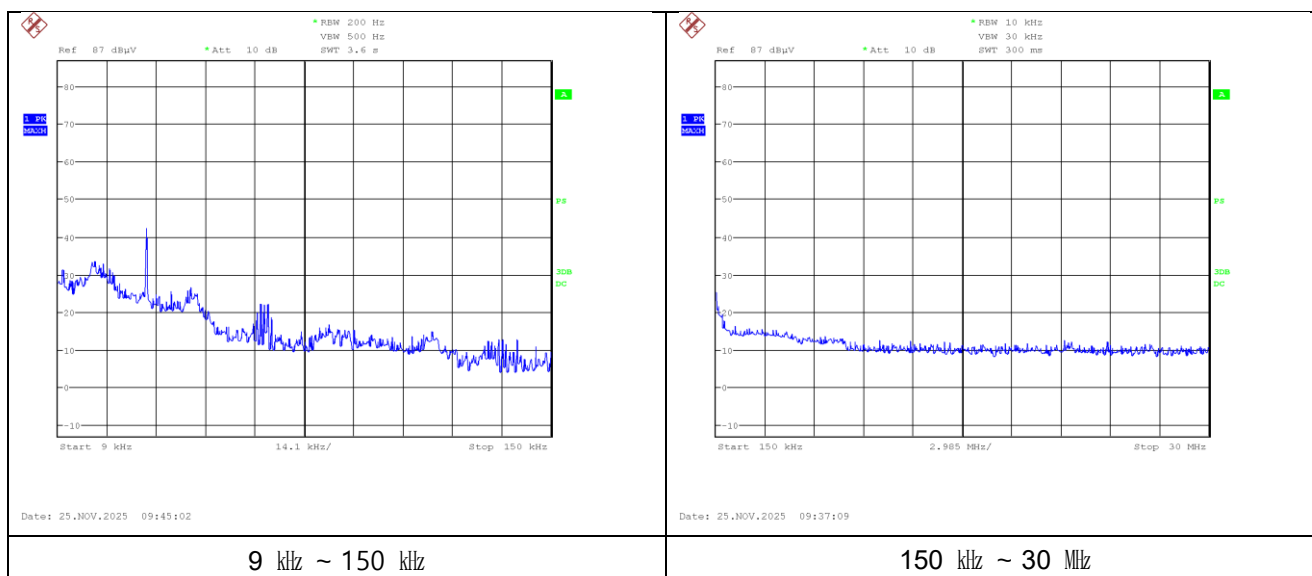
The frequency spectrum from 9 kHz to 1 000 MHz was investigated.

Radiated Emissions			Ant.	Correction Factors (dB/m)	Total	Limit	
Frequency (MHz)	Reading (dB μ V)	Detect Mode	Pol.		Actual (dB μ V/m)	Limit (dB μ V/m)	Margin (dB)
814.95	23.39	Quasi - Peak	H	2.87	26.26	46.00	19.74
Above 900.00	Not detected	-	-	-	-	-	-

Remark;

- Spurious emissions for all channels and modes were investigated and almost the same below 1 GHz.
- Test from 30 MHz to 1 000 MHz was performed using the software of ELEKTRA(V5.02) from Rohde & Schwarz GmbH & Co. KG.
- Reported spurious emissions are in **EDR / 3DH5 / High channel** as worst case among other modes.
- Radiated spurious emission measurement as below.
(Actual = Reading + Correction)
(Correction = Antenna Factor + AMP Factor + Cable Loss)
- According to §15.31(o), emission levels are not report much lower than the limits by over 20 dB.

- Test plots



2.4.2. Radiated Spurious Emission above 1 000 MHz

The frequency spectrum above 1 000 MHz was investigated. All reading values are peak values.

Operating Mode: GFSK

A. Low Channel (2 402 MHz)

Radiated Emissions			Ant.	Correction Factors			Total	Limit	
Frequency (MHz)	Reading (dBμV)	Detect Mode	Pol.	AF (dB/m)	CL (dB)	DF (dB)	Actual (dBμV/m)	Limit (dBμV/m)	Margin (dB)
*2 310.00	17.64	Peak	V	27.94	7.33	-	52.91	74.00	21.09
*2 310.00	-	Average	-	-	-	-18.74	34.17	54.00	19.83
*2 384.41	19.65	Peak	V	28.17	7.55	-	55.37	74.00	18.63
*2 384.41	-	Average	-	-	-	-18.74	36.63	54.00	17.37
*2 390.00	18.75	Peak	V	28.18	7.59	-	54.52	74.00	19.48
*2 390.00	-	Average	-	-	-	-18.74	35.78	54.00	18.22

Radiated Emissions			Ant.	Correction Factors			Total	Limit	
Frequency (MHz)	Reading (dBμV)	Detect Mode	Pol.	AF (dB/m)	AMP+CL (dB)	DF (dB)	Actual (dBμV/m)	Limit (dBμV/m)	Margin (dB)
*4 804.32	45.01	Peak	H	32.73	-28.61	-	49.13	74.00	24.87
Above 4 900.00	Not detected	-	-	-	-	-	-	-	-

B. Middle Channel (2 441 MHz)

Radiated Emissions			Ant.	Correction Factors			Total	Limit	
Frequency (MHz)	Reading (dBμV)	Detect Mode	Pol.	AF (dB/m)	AMP+CL (dB)	DF (dB)	Actual (dBμV/m)	Limit (dBμV/m)	Margin (dB)
*4 881.67	43.80	Peak	H	33.19	-28.00	-	48.99	74.00	25.01
Above 4 900.00	Not detected	-	-	-	-	-	-	-	-

C. High Channel (2 480 MHz)

Radiated Emissions			Ant.	Correction Factors			Total	Limit	
Frequency (MHz)	Reading (dB μ V)	Detect Mode	Pol.	AF (dB/m)	CL (dB)	DF (dB)	Actual (dB μ V/m)	Limit (dB μ V/m)	Margin (dB)
*2 483.50	20.11	Peak	V	28.34	7.58	-	56.03	74.00	17.97
*2 483.50	-	Average	-	-	-	-18.74	37.29	54.00	16.71
*2 483.53	20.48	Peak	V	28.34	7.58	-	56.40	74.00	17.60
*2 483.53	-	Average	-	-	-	-18.74	37.66	54.00	16.34
*2 500.00	19.18	Peak	V	28.50	7.74	-	55.42	74.00	18.58
*2 500.00	-	Average	-	-	-	-18.74	36.68	54.00	17.32

Radiated Emissions			Ant.	Correction Factors			Total	Limit	
Frequency (MHz)	Reading (dB μ V)	Detect Mode	Pol.	AF (dB/m)	AMP+CL (dB)	DF (dB)	Actual (dB μ V/m)	Limit (dB μ V/m)	Margin (dB)
*4 959.78	40.87	Peak	H	33.42	-27.81	-	46.48	74.00	27.52
Above 5 000.00	Not detected	-	-	-	-	-	-	-	-

Operating Mode: 8DPSK

A. Low Channel (2 402 MHz)

Radiated Emissions			Ant.	Correction Factors			Total	Limit	
Frequency (MHz)	Reading (dBμV)	Detect Mode	Pol.	AF (dB/m)	CL (dB)	DF (dB)	Actual (dBμV/m)	Limit (dBμV/m)	Margin (dB)
*2 310.00	18.32	Peak	V	27.94	7.33	-	53.59	74.00	20.41
*2 310.00	-	Average	-	-	-	-18.74	34.85	54.00	19.15
*2 356.13	19.86	Peak	V	28.11	7.34	-	55.31	74.00	18.69
*2 356.13	-	Average	-	-	-	-18.74	36.57	54.00	17.43
*2 390.00	18.55	Peak	V	28.18	7.59	-	54.32	74.00	19.68
*2 390.00	-	Average	-	-	-	-18.74	35.58	54.00	18.42

Radiated Emissions			Ant.	Correction Factors			Total	Limit	
Frequency (MHz)	Reading (dBμV)	Detect Mode	Pol.	AF (dB/m)	AMP+CL (dB)	DF (dB)	Actual (dBμV/m)	Limit (dBμV/m)	Margin (dB)
*4 803.97	43.55	Peak	H	32.72	-28.61	-	47.66	74.00	26.34
Above 4 900.00	Not detected	-	-	-	-	-	-	-	-

B. Middle Channel (2 441 MHz)

Radiated Emissions			Ant.	Correction Factors			Total	Limit	
Frequency (MHz)	Reading (dBμV)	Detect Mode	Pol.	AF (dB/m)	AMP+CL (dB)	DF (dB)	Actual (dBμV/m)	Limit (dBμV/m)	Margin (dB)
*4 882.01	41.55	Peak	H	33.19	-28.00	-	46.74	74.00	27.26
Above 4 900.00	Not detected	-	-	-	-	-	-	-	-

C. High Channel (2 480 MHz)

Radiated Emissions			Ant.	Correction Factors			Total	Limit	
Frequency (MHz)	Reading (dBμV)	Detect Mode	Pol.	AF (dB/m)	CL (dB)	DF (dB)	Actual (dBμV/m)	Limit (dBμV/m)	Margin (dB)
*2 483.50	18.70	Peak	V	28.34	7.58	-	54.62	74.00	19.38
*2 483.50	-	Average	-	-	-	-18.74	35.88	54.00	18.12
*2 483.60	22.97	Peak	V	28.34	7.58	-	58.89	74.00	15.11
*2 483.60	-	Average	-	-	-	-18.74	40.15	54.00	13.85
*2 500.00	18.51	Peak	V	28.50	7.74	-	54.75	74.00	19.25
*2 500.00	-	Average	-	-	-	-18.74	36.01	54.00	17.99

Radiated Emissions			Ant.	Correction Factors			Total	Limit	
Frequency (MHz)	Reading (dBμV)	Detect Mode	Pol.	AF (dB/m)	AMP+CL (dB)	DF (dB)	Actual (dBμV/m)	Limit (dBμV/m)	Margin (dB)
*4 959.52	39.37	Peak	H	33.42	-27.81	-	44.98	74.00	29.02
Above 5 000.00	Not detected	-	-	-	-	-	-	-	-

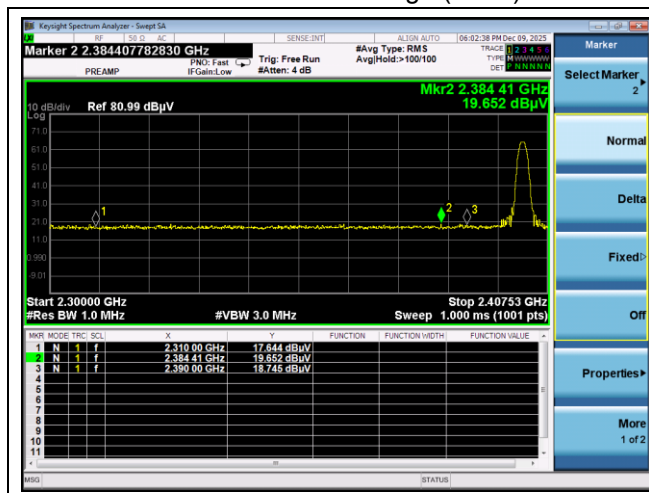
Remark;

1. “*” means the restricted band.
2. Measuring frequencies from 1 GHz to the 10th harmonic of highest fundamental frequency.
3. Radiated emissions measured in frequency above 1 000 MHz were made with an instrument using peak/average detector mode.
4. Actual = Reading + AF + CL + (DF) or Reading + AF + AMP + CL + (DF).
5. According to § 15.31(o), emission levels are not reported much lower than the limits by over 20 dB.
6. The maximized peak measured value complies with the average limit, to perform an average measurement is unnecessary.

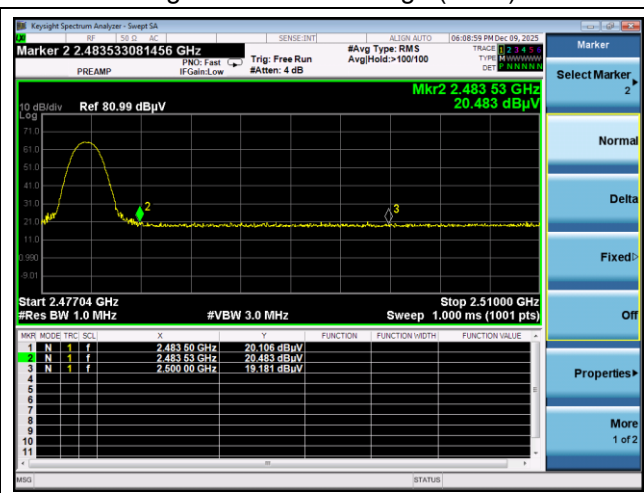
- Test plots

Mode: GFSK

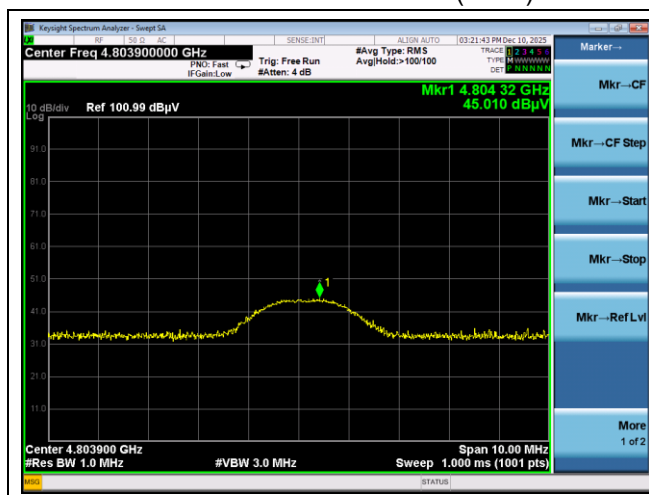
Low channel band edge (Peak)



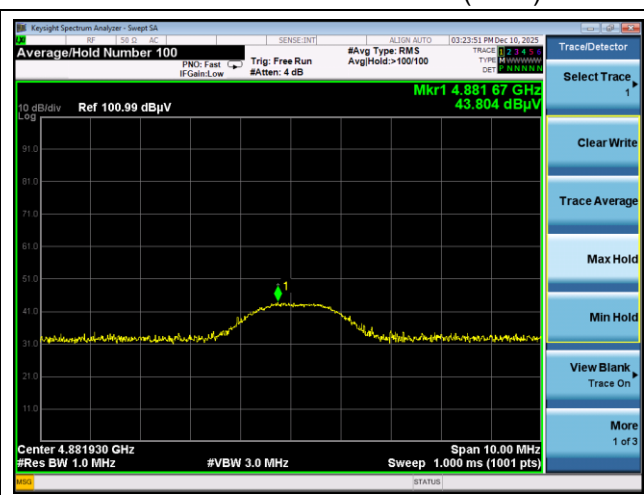
High channel band edge (Peak)



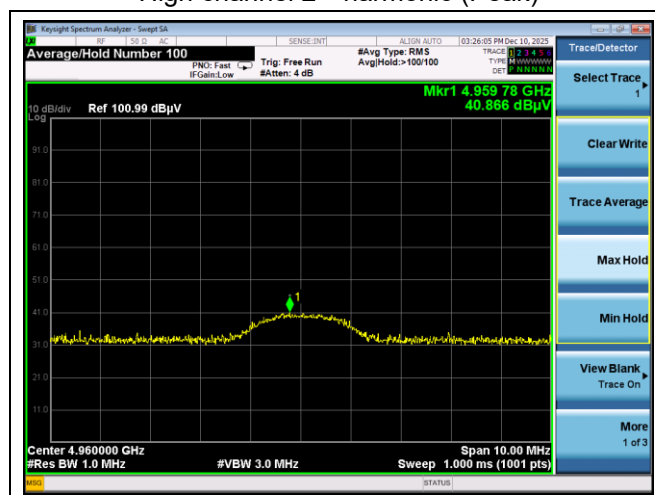
Low channel 2nd harmonic (Peak)



Middle channel 2nd harmonic (Peak)

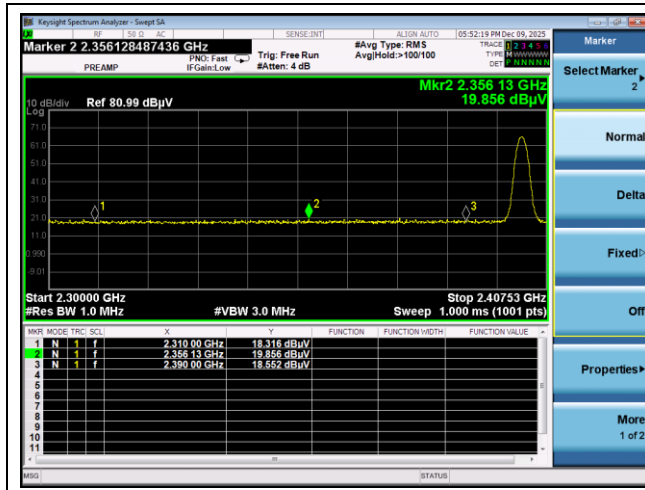


High channel 2nd harmonic (Peak)

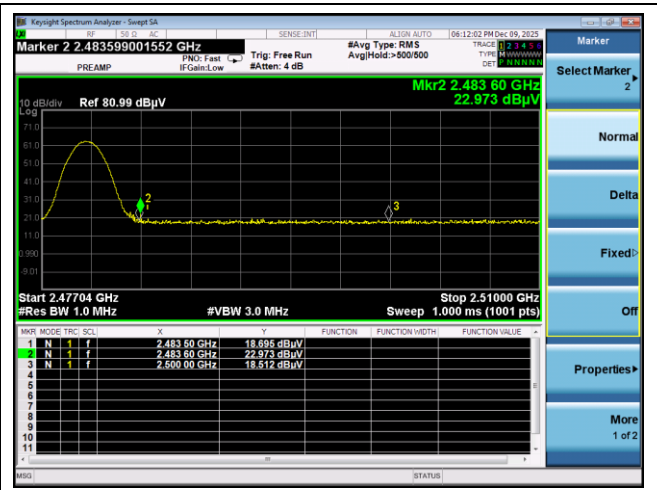


Mode: 8DPSK

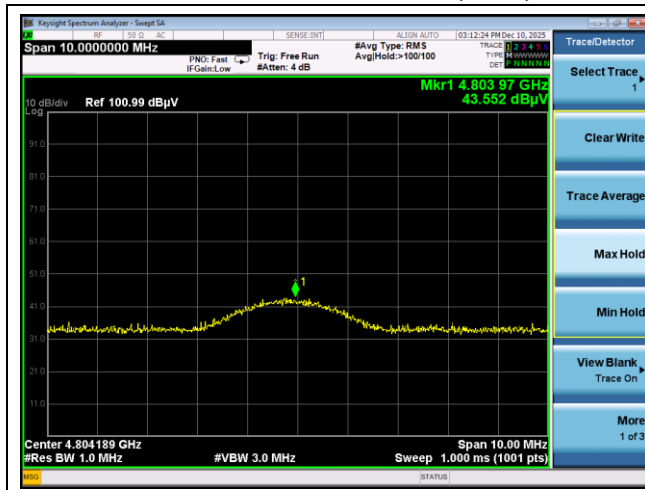
Low channel band edge (Peak)



High channel band edge (Peak)



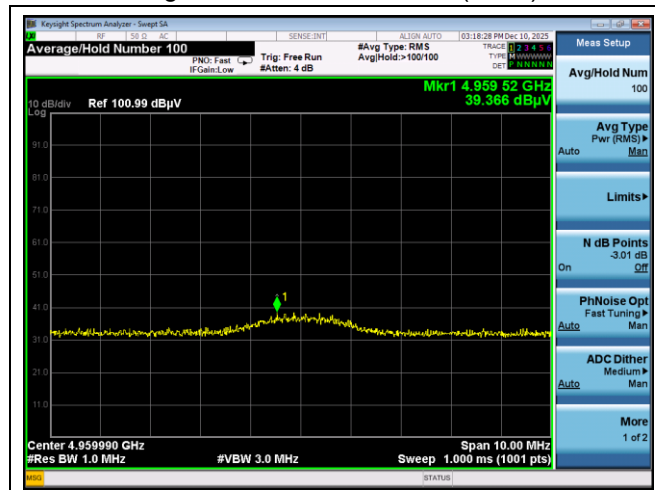
Low channel 2nd harmonic (Peak)



Middle channel 2nd harmonic (Peak)



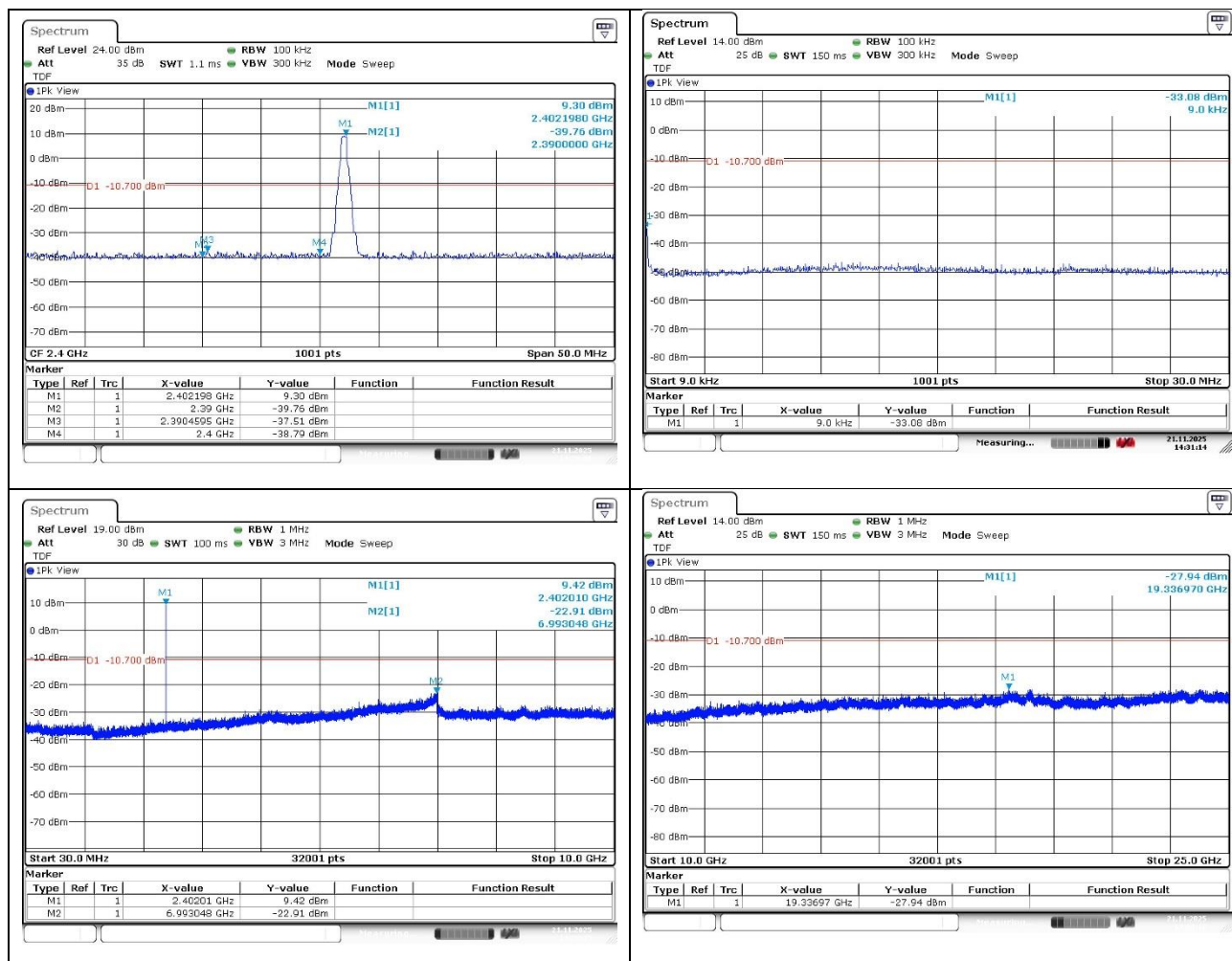
High channel 2nd harmonic (Peak)



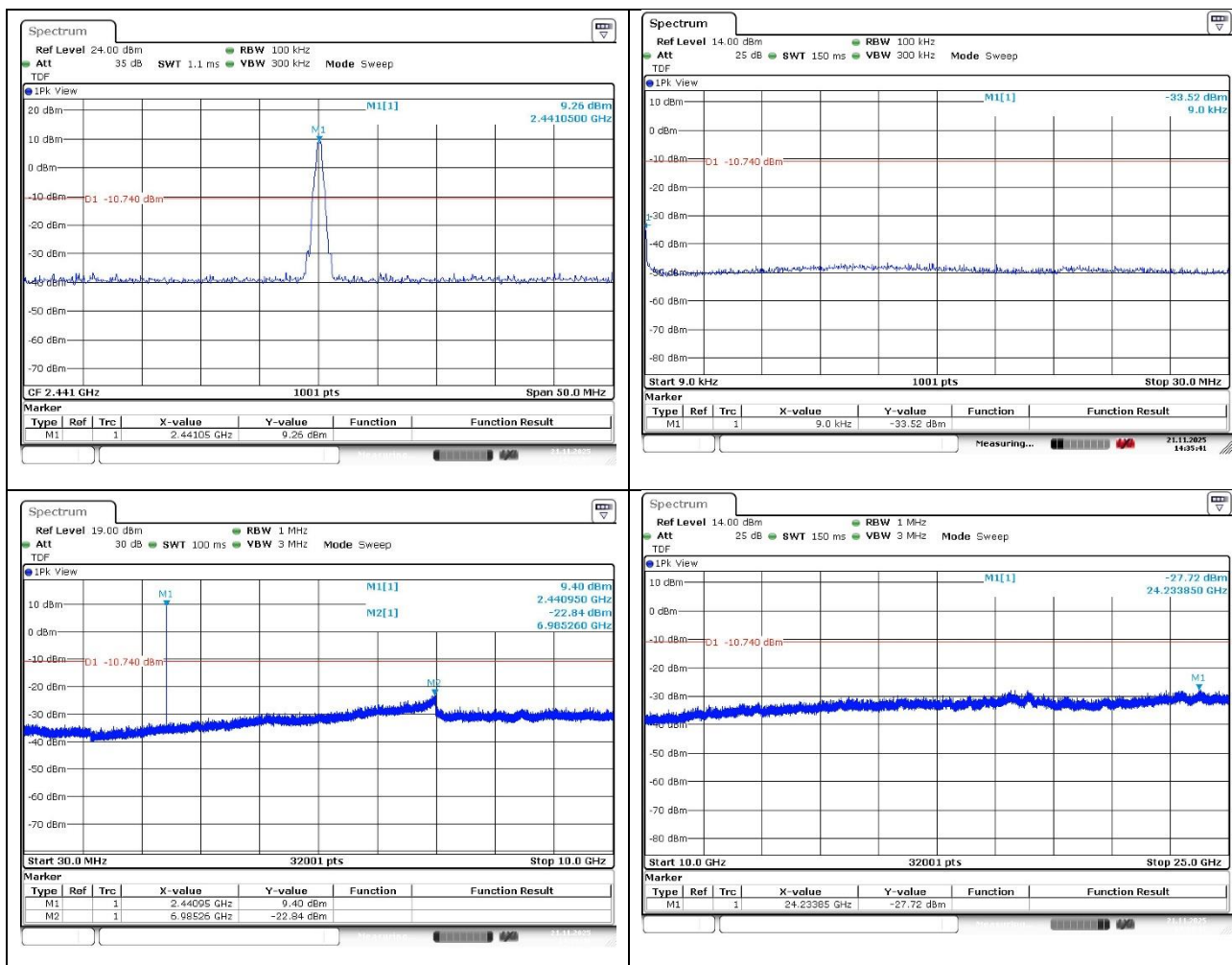
2.4.3. Plot of Conducted Spurious Emissions

Mode: GFSK_hopping function turned off

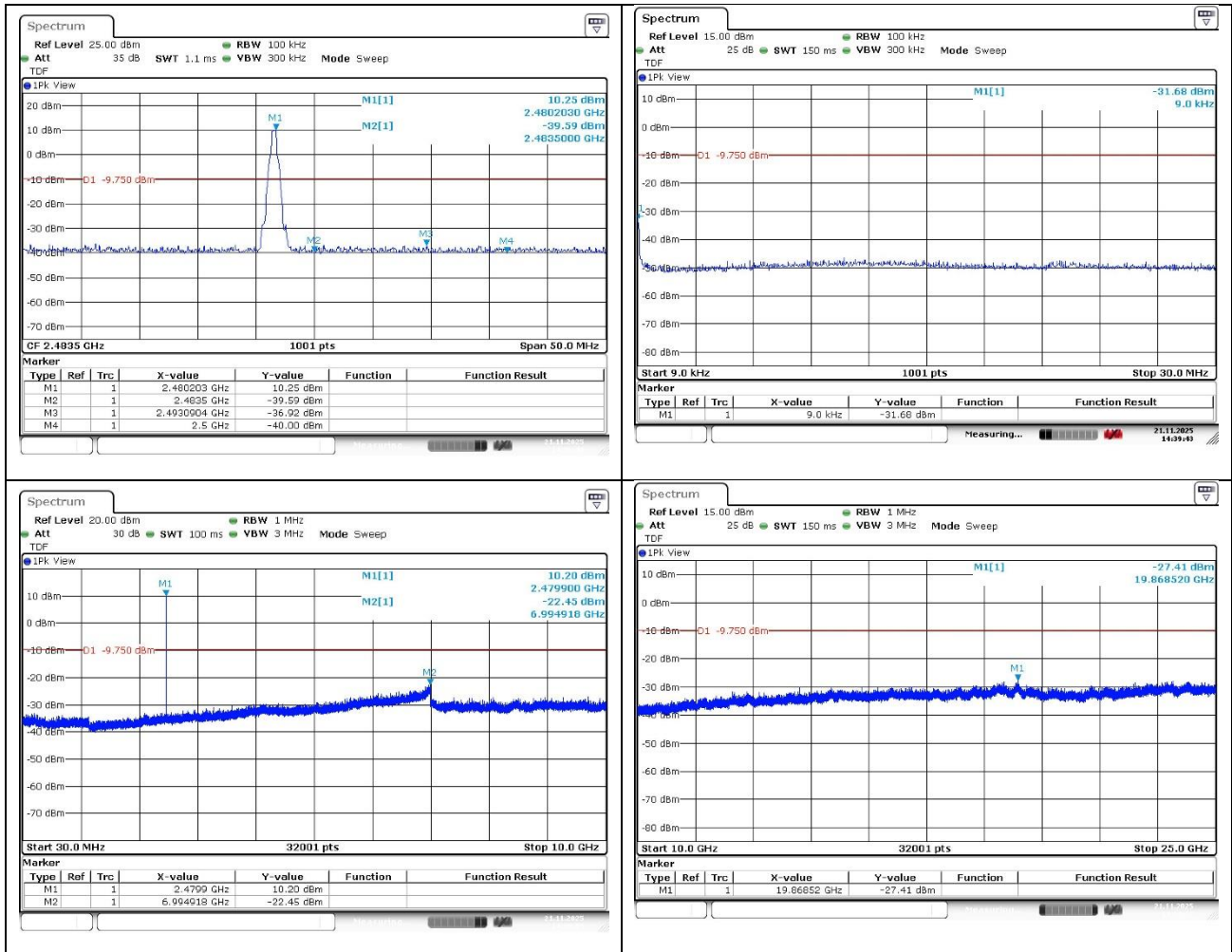
- Low Channel



- Middle Channel



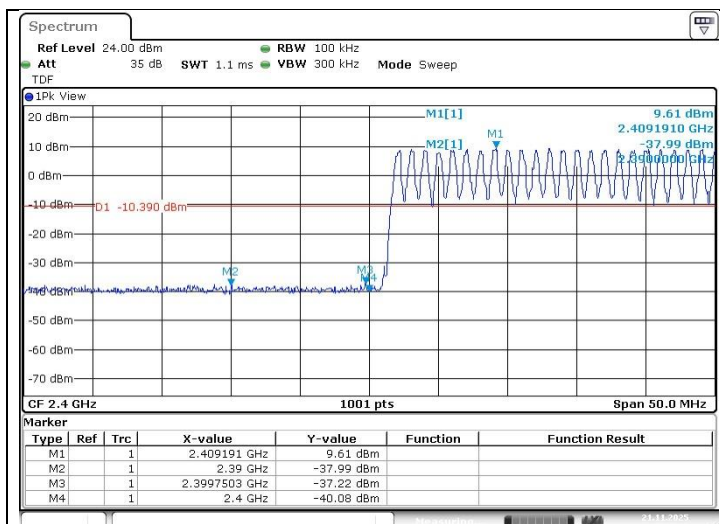
- High Channel



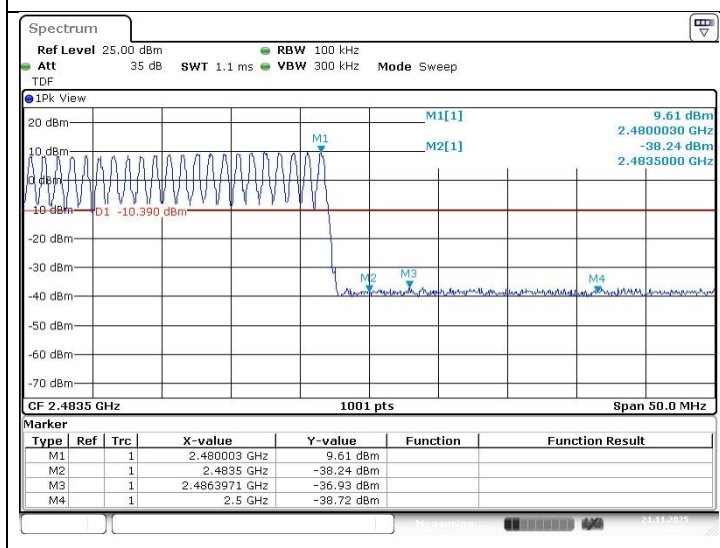
Mode: GFSK_hopping function turned on

Band edge compliance

Low Channel

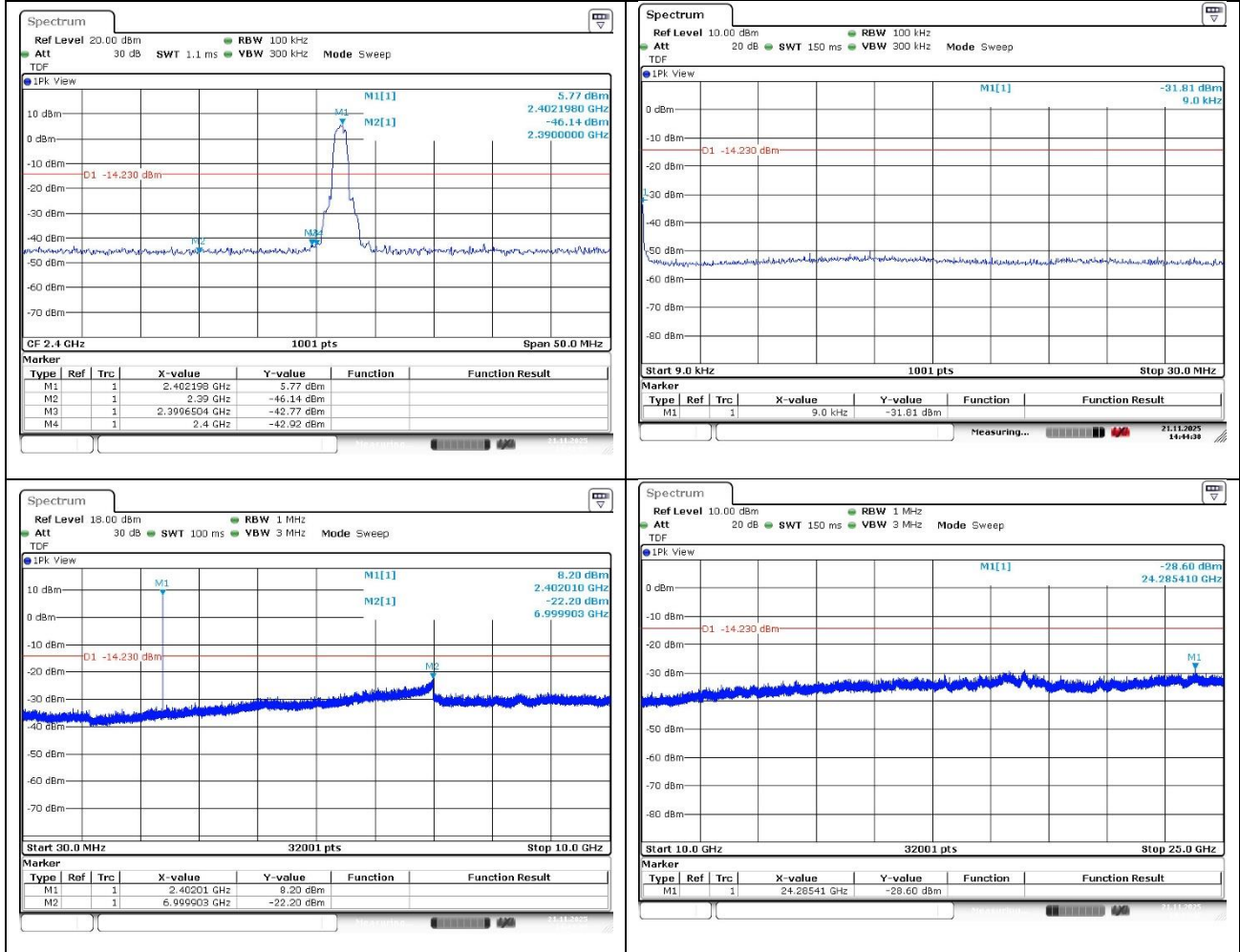


High Channel

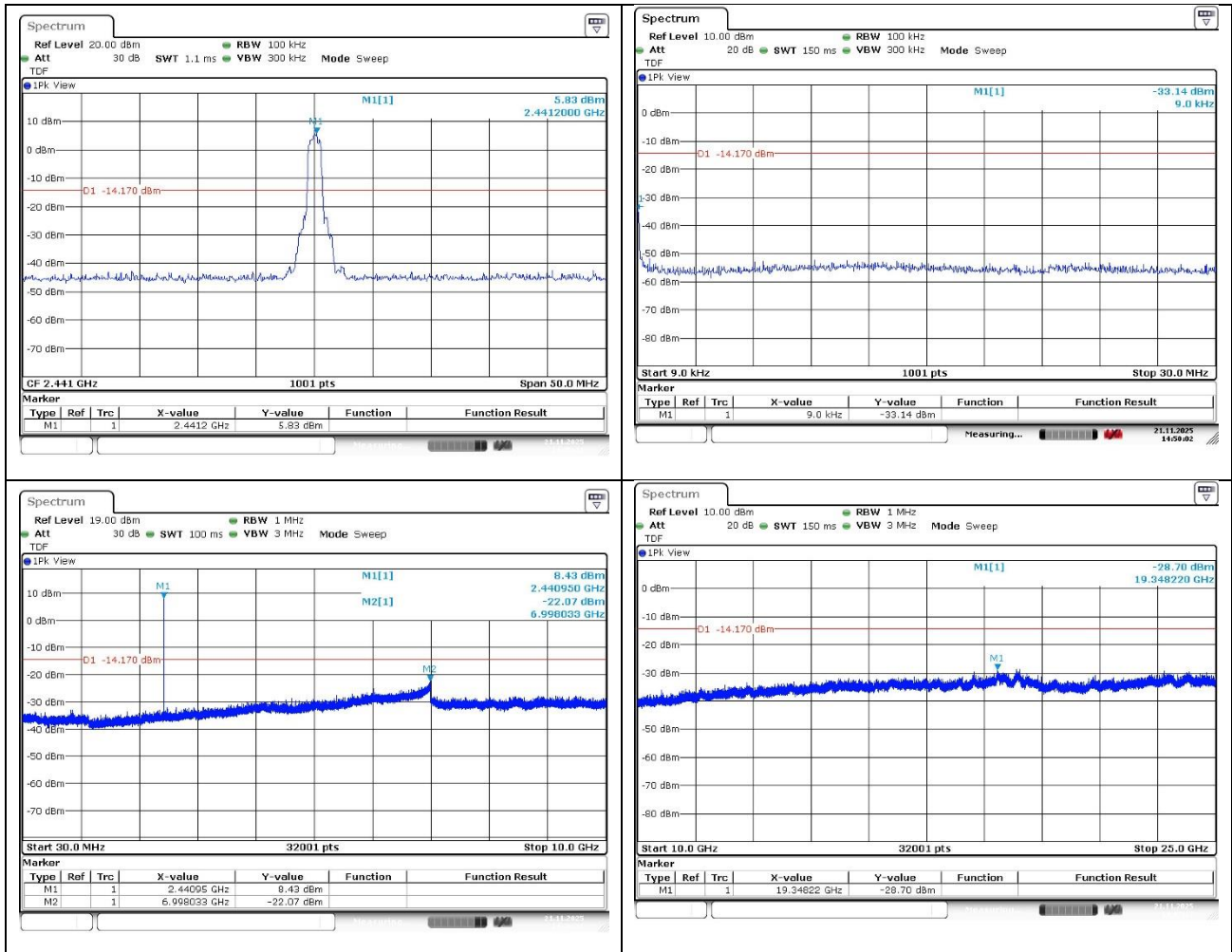


Mode: 8DPSK_hopping function turned off

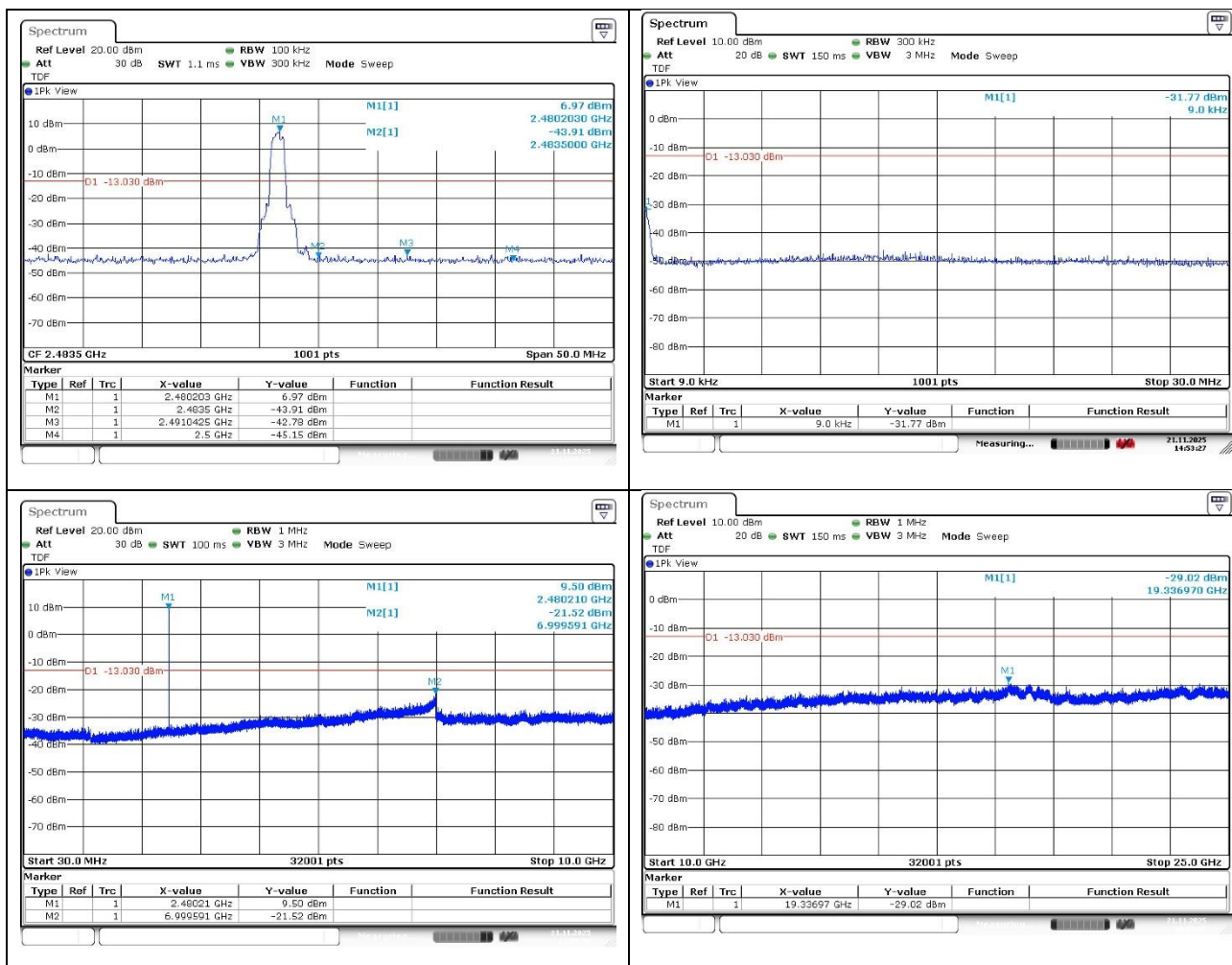
- Low Channel



- Middle Channel



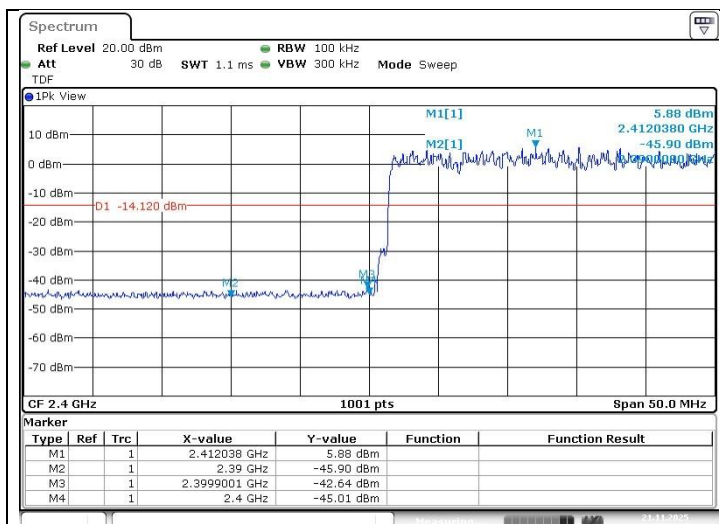
- High Channel



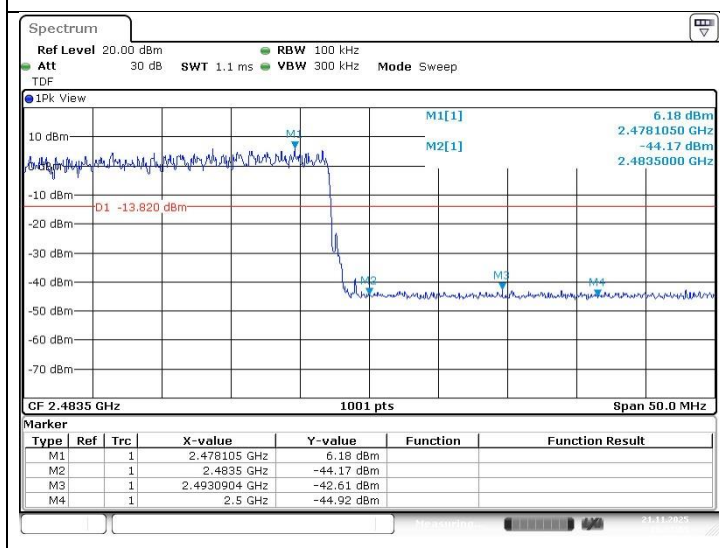
Mode: 8DPSK_hopping function turned on

Band edge compliance

Low channel

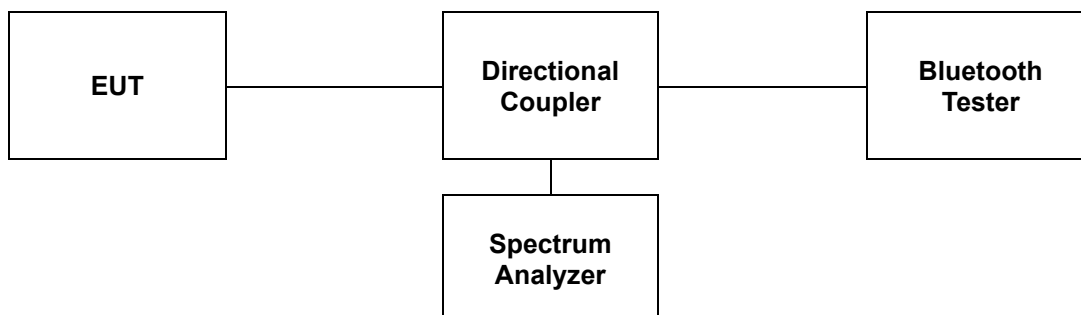


High channel



3. 20 dB Bandwidth and 99 % Bandwidth

3.1. Test Setup



3.2. Limit

Limit: Not Applicable

3.3. Test Procedure

3.3.1. 20 dB Bandwidth

The test follows ANSI C63.10-2020+Cor.1-2023.

The 20 dB bandwidth was measured with a spectrum analyzer connected to RF antenna connector (conducted measurement) while EUT was operating in transmit mode at the appropriate center frequency.

Use the following spectrum analyzer setting:

1. Span = approximately 2 to 5 times the 20 dB bandwidth.
2. RBW $\geq$ 1 % to 5 % of the 20 dB bandwidth.
3. VBW $\geq$ 3 x RBW
4. Sweep = auto
5. Detector = peak
6. Trace = max hold

The marker-to-peak function to set the mark to the peak of the emission. Use the marker-delta function to measure 20 dB down one side of the emission. Reset the function, and move the marker to the other side of the emission, until it is (as close as possible to) even with the reference marker level. The marker-delta reading at this point is 20 dB bandwidth of the emission.

3.3.2. 99 % Bandwidth

The test follows section 6.9.3 of ANSI C63.10-2020+Cor.1-2023.

The occupied bandwidth is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers are each equal to 0.5% of the total mean power of the given emission. The following procedure shall be used for measuring 99% power bandwidth:

- a) The instrument center frequency is set to the nominal EUT channel center frequency. The frequency span for the spectrum analyzer shall be between 1.5 times and 5.0 times the OBW.
- b) The nominal IF filter bandwidth (3 dB RBW) shall be in the range of 1% to 5% of the OBW, and VBW shall be at least three times the RBW, unless otherwise specified by the applicable requirement.
- c) Set the reference level of the instrument as required, keeping the signal from exceeding the maximum input mixer level for linear operation. In general, the peak of the spectral envelope shall be more than $[10 \log (OBW/RBW)]$ below the reference level. Specific guidance is given in 4.1.6.2.
- d) Step a) through step c) might require iteration to adjust within the specified range.
- e) Video averaging is not permitted. Where practical, a sample detection and single sweep mode shall be used. Otherwise, peak detection and max-hold mode (until the trace stabilizes) shall be used.
- f) Use the 99% power bandwidth function of the instrument (if available) and report the measured bandwidth.
- g) If the instrument does not have a 99% power bandwidth function, then the trace data points are recovered and directly summed in linear power terms. The recovered amplitude data points, beginning at the lowest frequency, are placed in a running sum until 0.5% of the total is reached; that frequency is recorded as the lower frequency. The process is repeated until 99.5% of the total is reached; that frequency is recorded as the upper frequency. The 99% power bandwidth is the difference between these two frequencies.
- h) The occupied bandwidth shall be reported by providing spectral plot(s) of the measuring instrument display; the plot axes and the scale units per division shall be clearly labeled. Tabular data may be reported in addition to the plot(s).

3.4. Test Results

Ambient temperature : $(23 \pm 1) ^\circ\text{C}$
 Relative humidity : 47 %

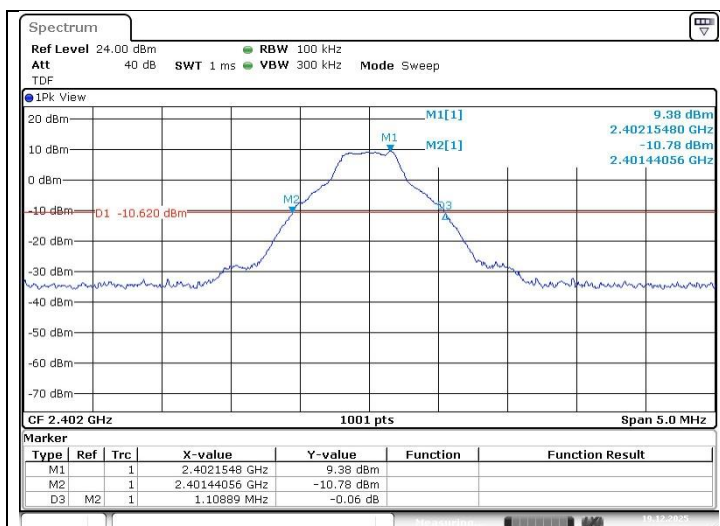
Mode	Data Rate (Mbps)	Channel	Frequency (MHz)	20 dB Bandwidth (MHz)	99 % Bandwidth (MHz)
GFSK	1	Low	2 402	1.109	0.875
		Middle	2 441	1.114	0.878
		High	2 480	1.114	0.878
$\pi/4$ DQPSK	2	Low	2 402	1.409	1.187
		Middle	2 441	1.409	1.187
		High	2 480	1.409	1.187
8DPSK	3	Low	2 402	1.389	1.193
		Middle	2 441	1.394	1.193
		High	2 480	1.394	1.196

- Test plots

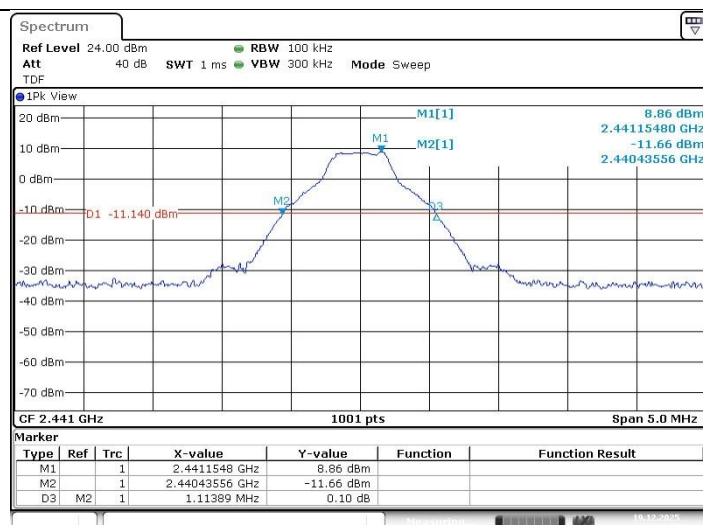
20 dB Bandwidth

Mode: GFSK

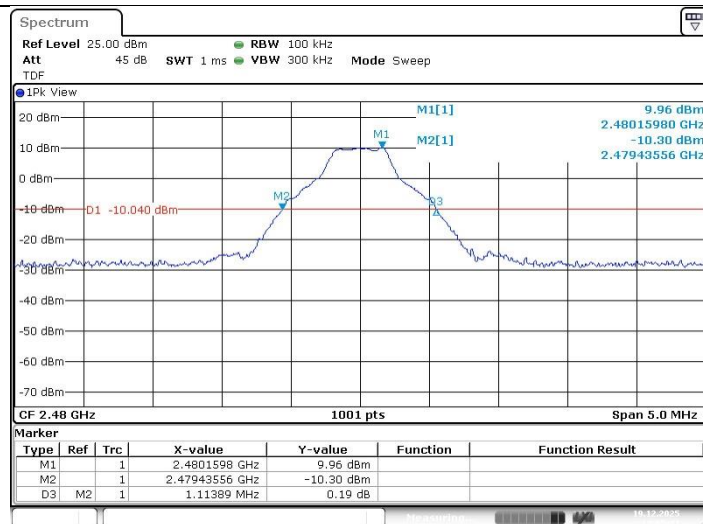
Low Channel



Middle Channel

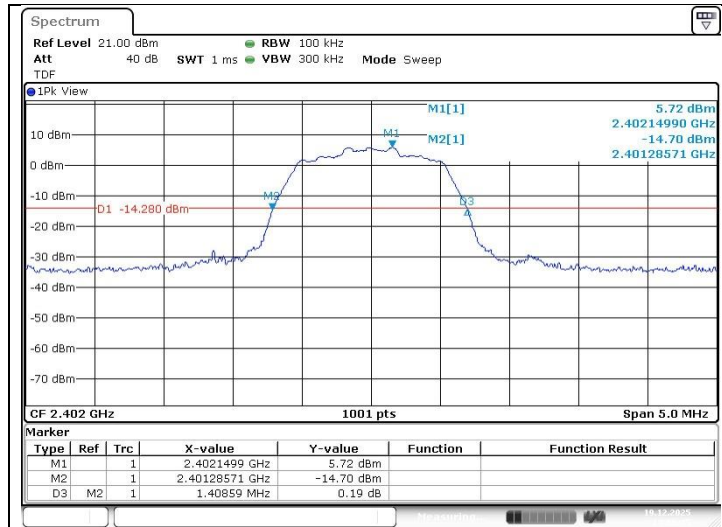


High Channel

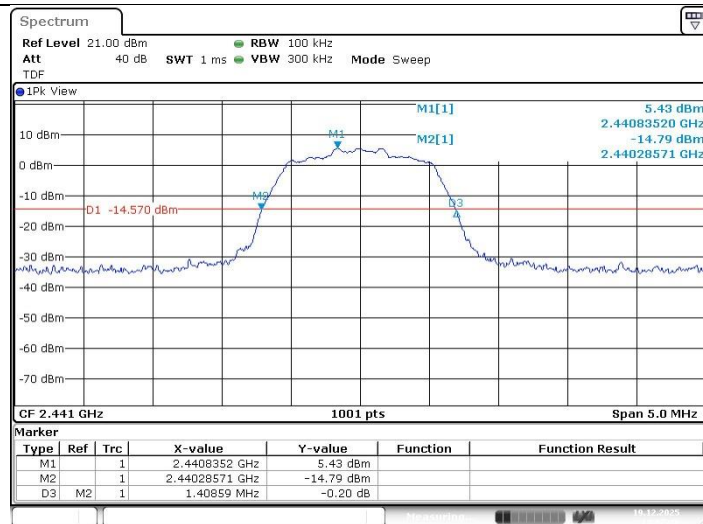


Mode: $\pi/4$ DQPSK

Low Channel



Middle Channel



High Channel

